

MIPS Germanium Detectors

Erick Young

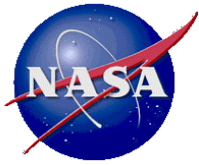
October 22, 1999



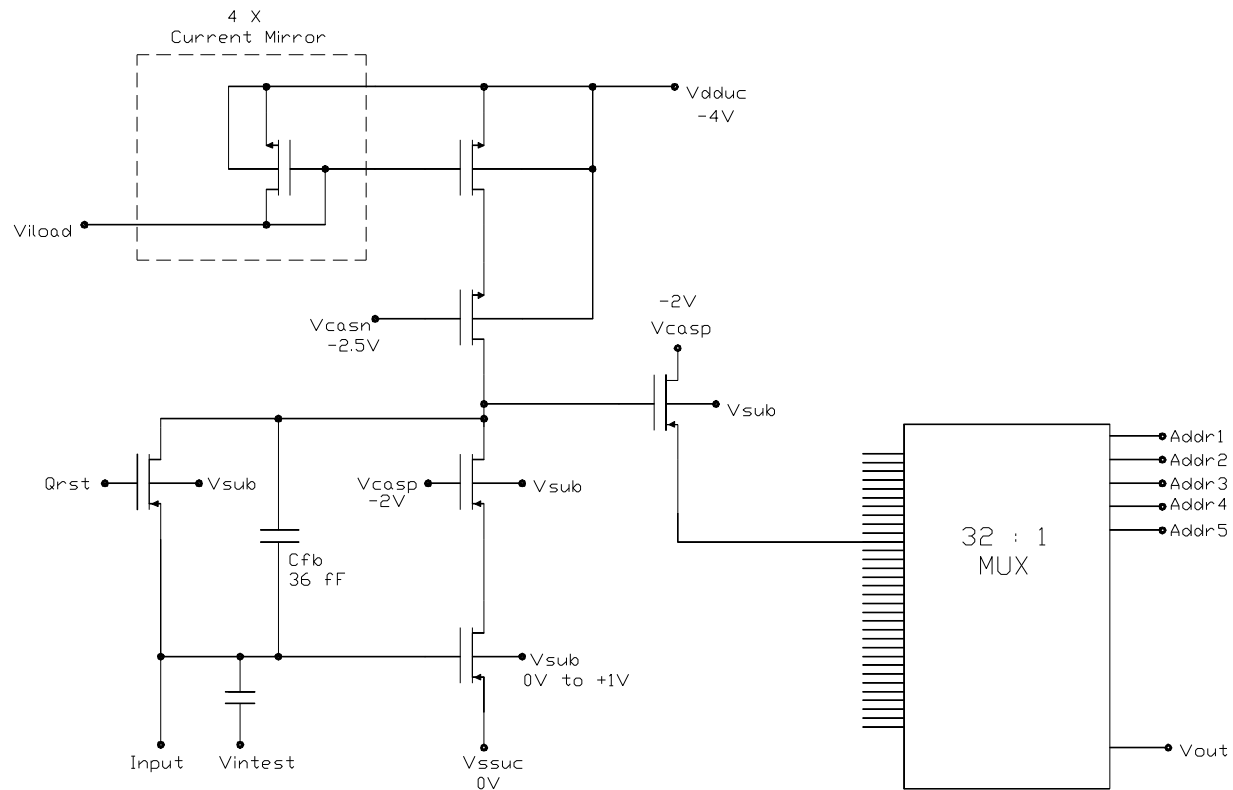
MIPS Detector Arrays

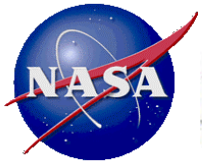
SIRTF

Band	Detector Type	Format	Wavelength Coverage (μm)
24 μm	Si:As BIB	128 x 128	20.5 – 26.5
70 μm	Ge:Ga	32 x 32	60 – 80 50 - 95
160 μm	Stressed Ge:Ga	2 x 20	140 - 180

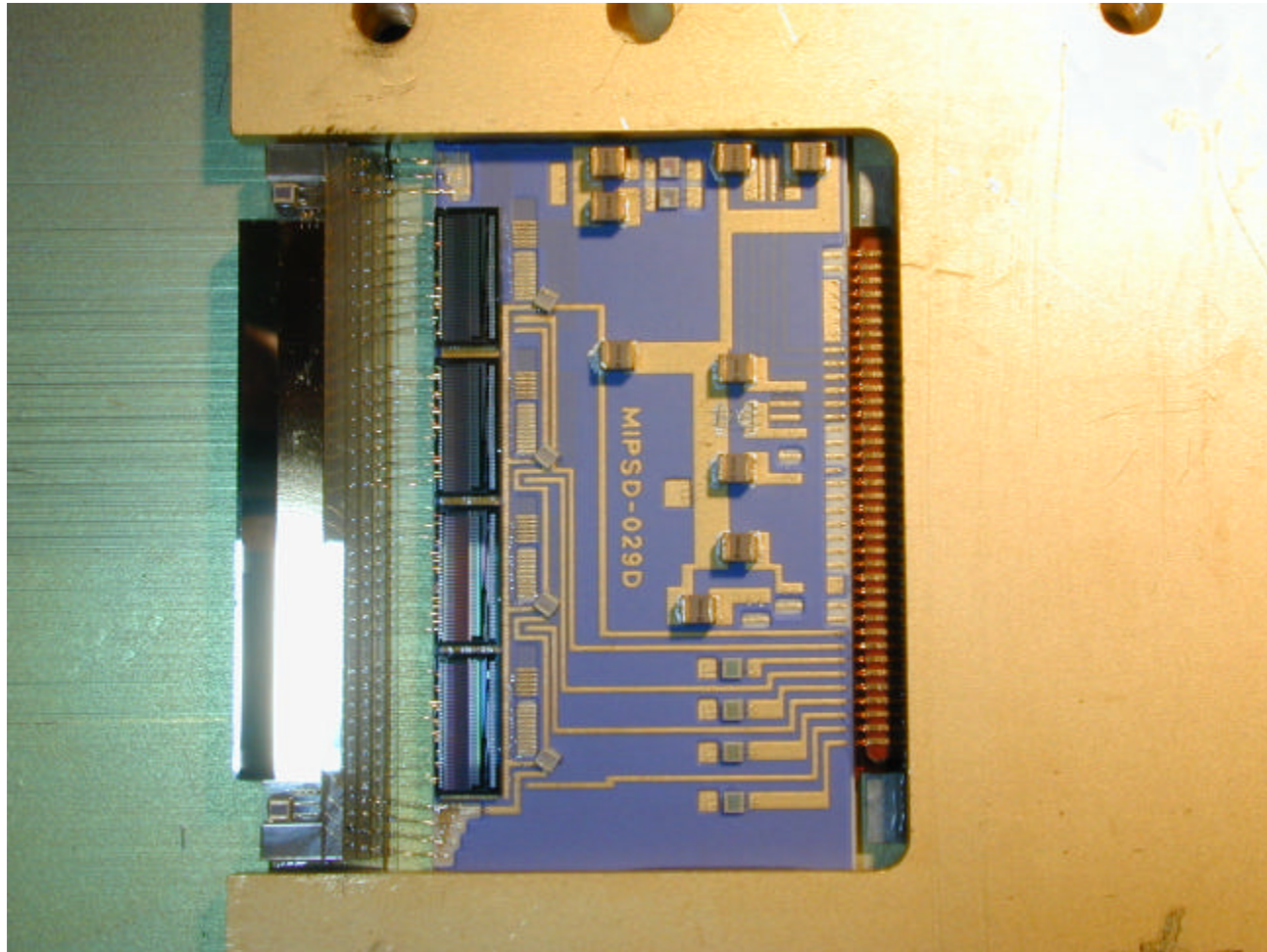


CRC-696 Readout Schematic Capacitive Transimpedance Amplifier





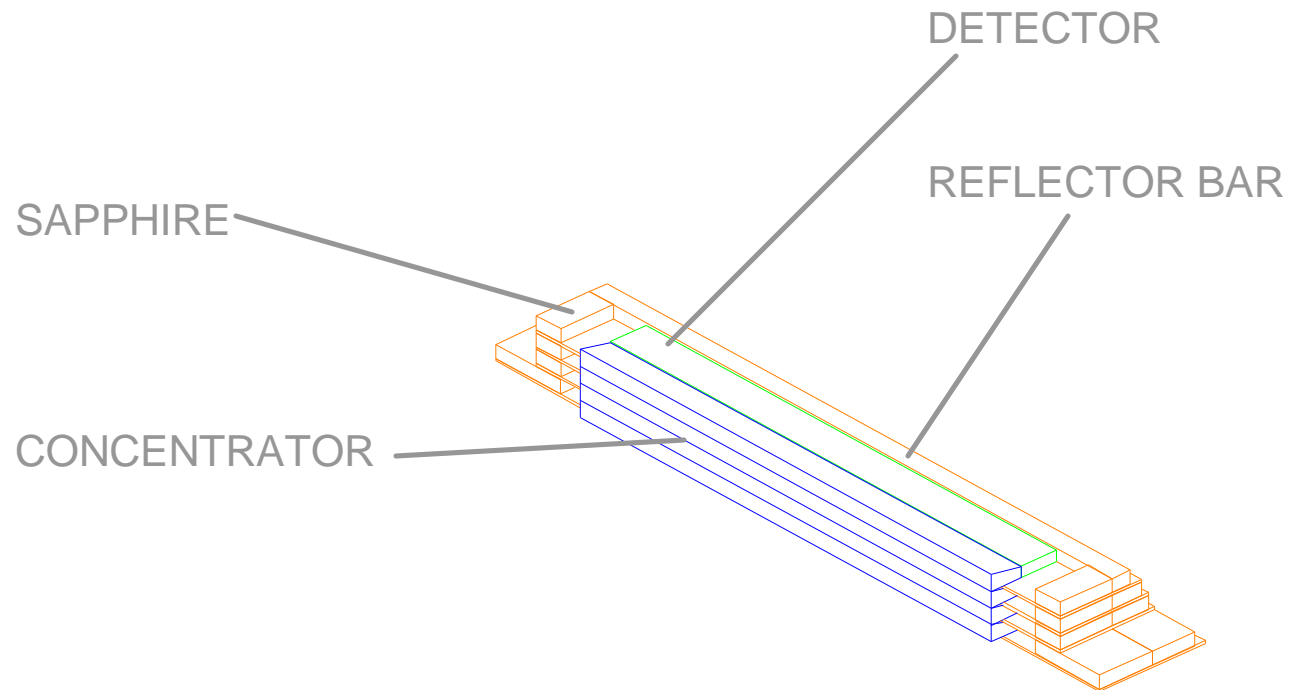
70 μm 4x32 Array Module Detail





Front End Detail

SIRTF





70 μm Array

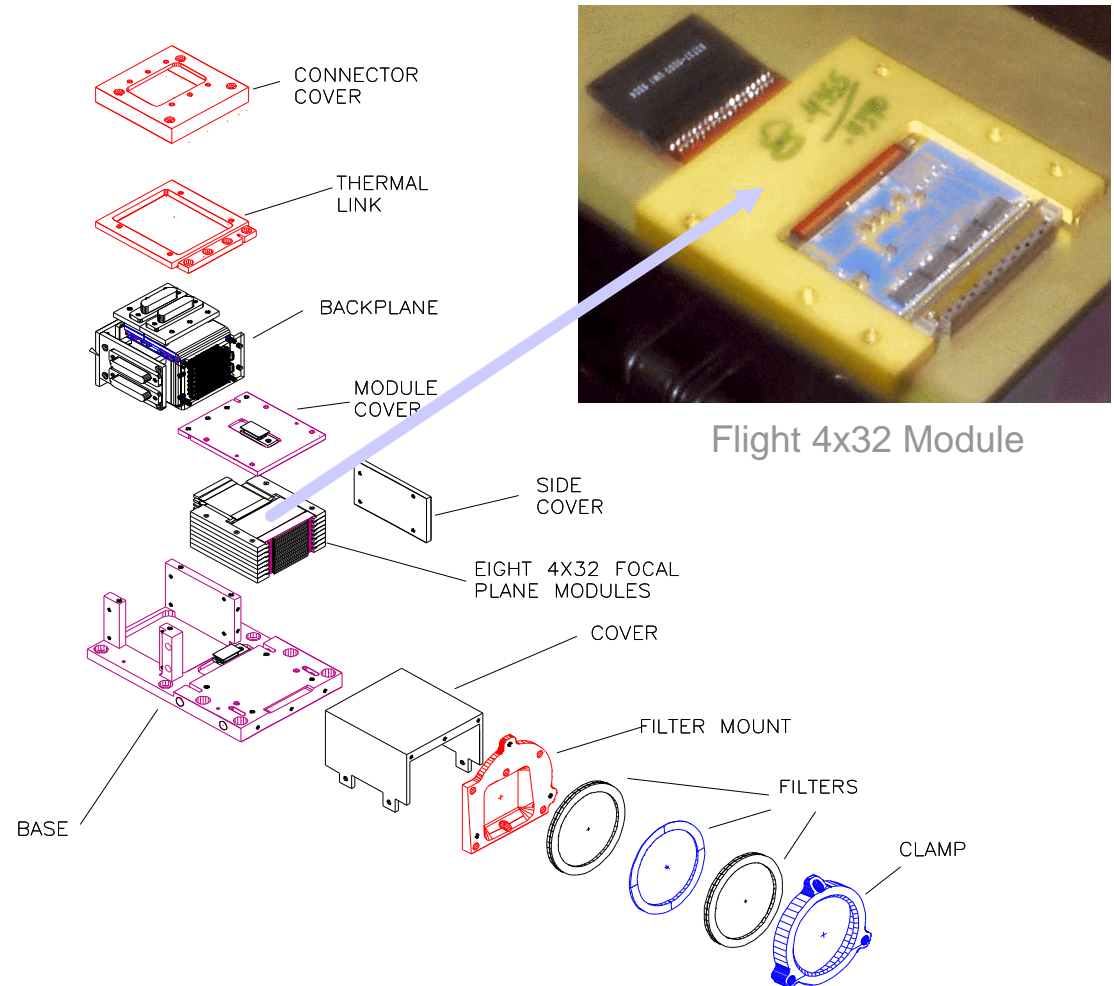


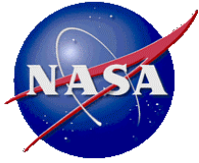
**32 x 32 Ge:Ga
photoconductor
array**

**Developed and constructed
at
Steward Observatory**

**Detector material from
Lawrence Berkeley
Laboratory**

**Custom cryogenic readouts
(CRC-696)**





Pixel Addressing Order



Ge:Ga ARRAY ADDRESSING SCHEME

4	8	12	16	20	24	28	32	4	8	12	16	20	24	28	32	4	8	12	16	20	24	28	32
3	7	11	15	19	23	27	31	3	7	11	15	19	23	27	31	3	7	11	15	19	23	27	31
2	6	10	14	18	22	26	30	2	6	10	14	18	22	26	30	2	6	10	14	18	22	26	30
1	5	9	13	17	21	25	29	1	5	9	13	17	21	25	29	1	5	9	13	17	21	25	29

MODULE 8

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4	8	12	16	20	24	28	32	4	8	12	16	20	24	28	32	4	8	12	16	20	24	28	32
3	7	11	15	19	23	27	31	3	7	11	15	19	23	27	31	3	7	11	15	19	23	27	31
2	6	10	14	18	22	26	30	2	6	10	14	18	22	26	30	2	6	10	14	18	22	26	30
1	5	9	13	17	21	25	29	1	5	9	13	17	21	25	29	1	5	9	13	17	21	25	29

MODULE 2

4	8	12	16	20	24	28	32	4	8	12	16	20	24	28	32	4	8	12	16	20	24	28	32
3	7	11	15	19	23	27	31	3	7	11	15	19	23	27	31	3	7	11	15	19	23	27	31
2	6	10	14	18	22	26	30	2	6	10	14	18	22	26	30	2	6	10	14	18	22	26	30
1	5	9	13	17	21	25	29	1	5	9	13	17	21	25	29	1	5	9	13	17	21	25	29

MODULE 1

BLOCK 1

BLOCK 2

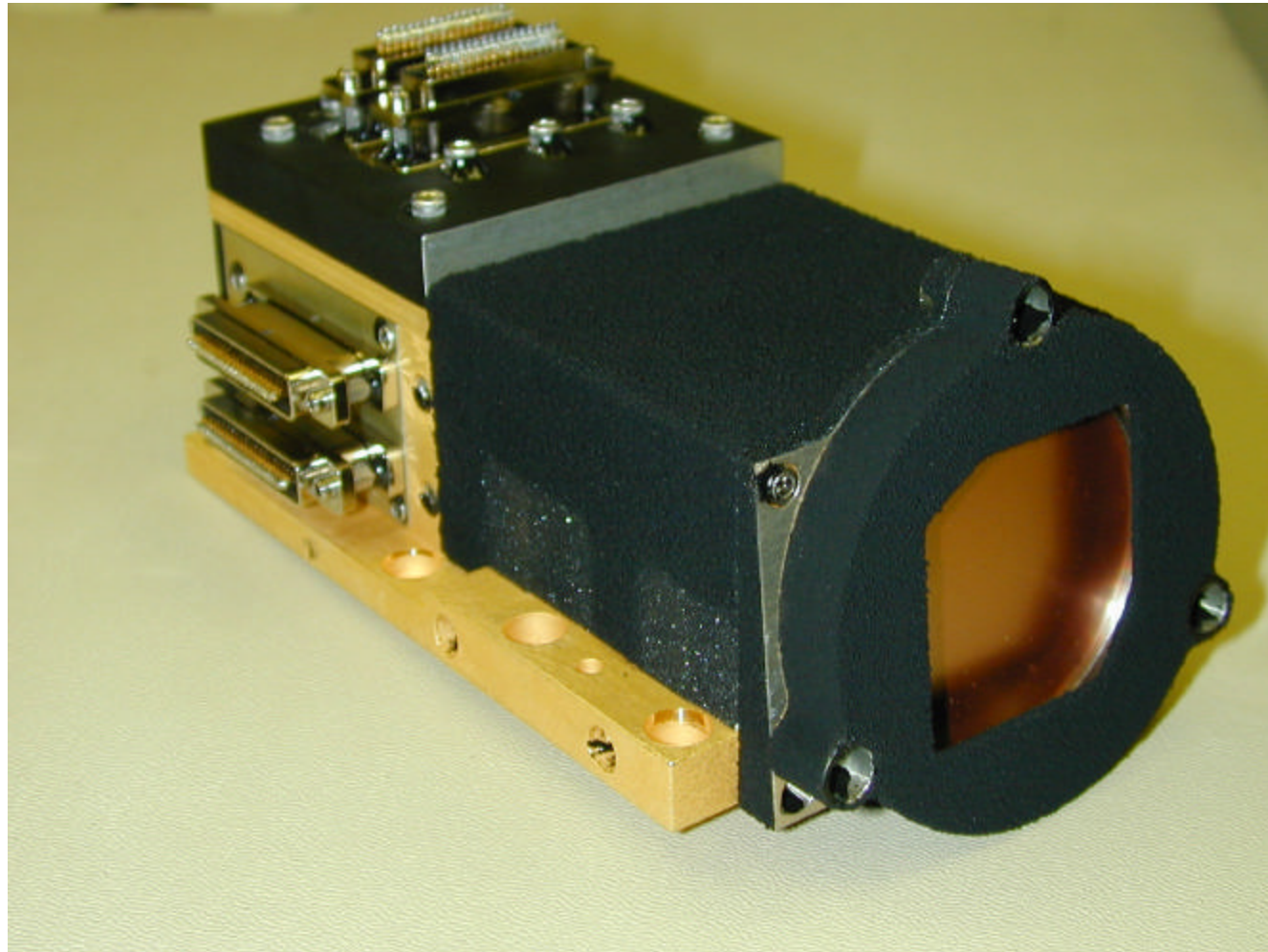
BLOCK 3

BLOCK 4



Flight 70 μm Array

SIRTF





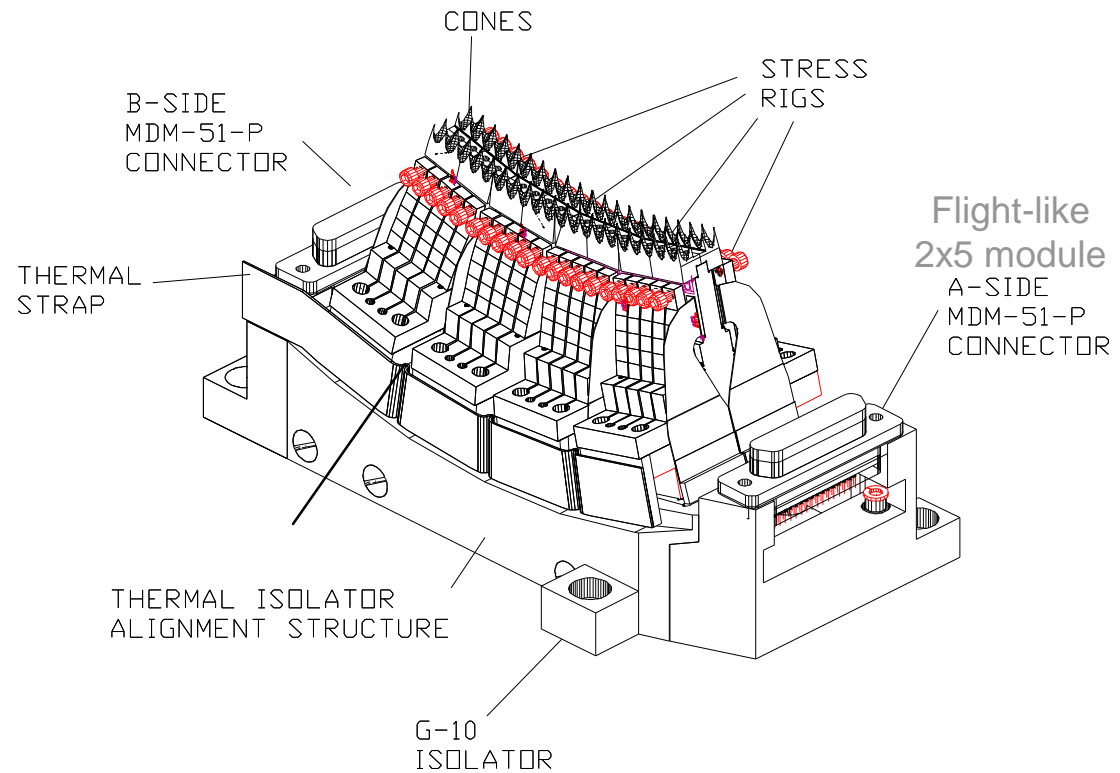
160 μm Array

2 x 20 Stressed Ge:Ga photoconductor array

Developed and constructed at Steward Observatory

Detector material from Lawrence Berkeley Laboratory

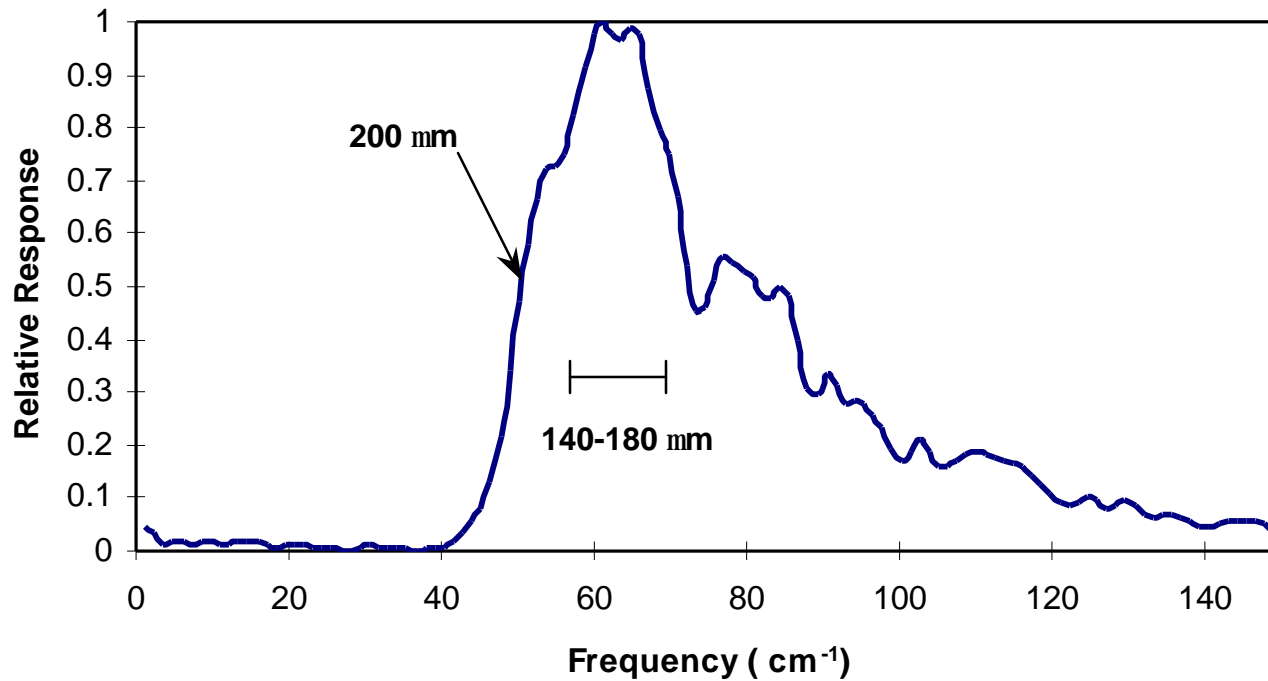
Custom cryogenic readouts (CRC-696)





Stressed Detector Spectral Response

**Stressed Detector Element#2
Raw Response**

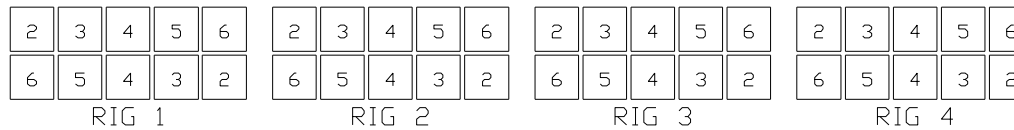




Stress Array Pixel Order



VIEW FROM FRONT OF STRESS Ge:Ga ARRAY



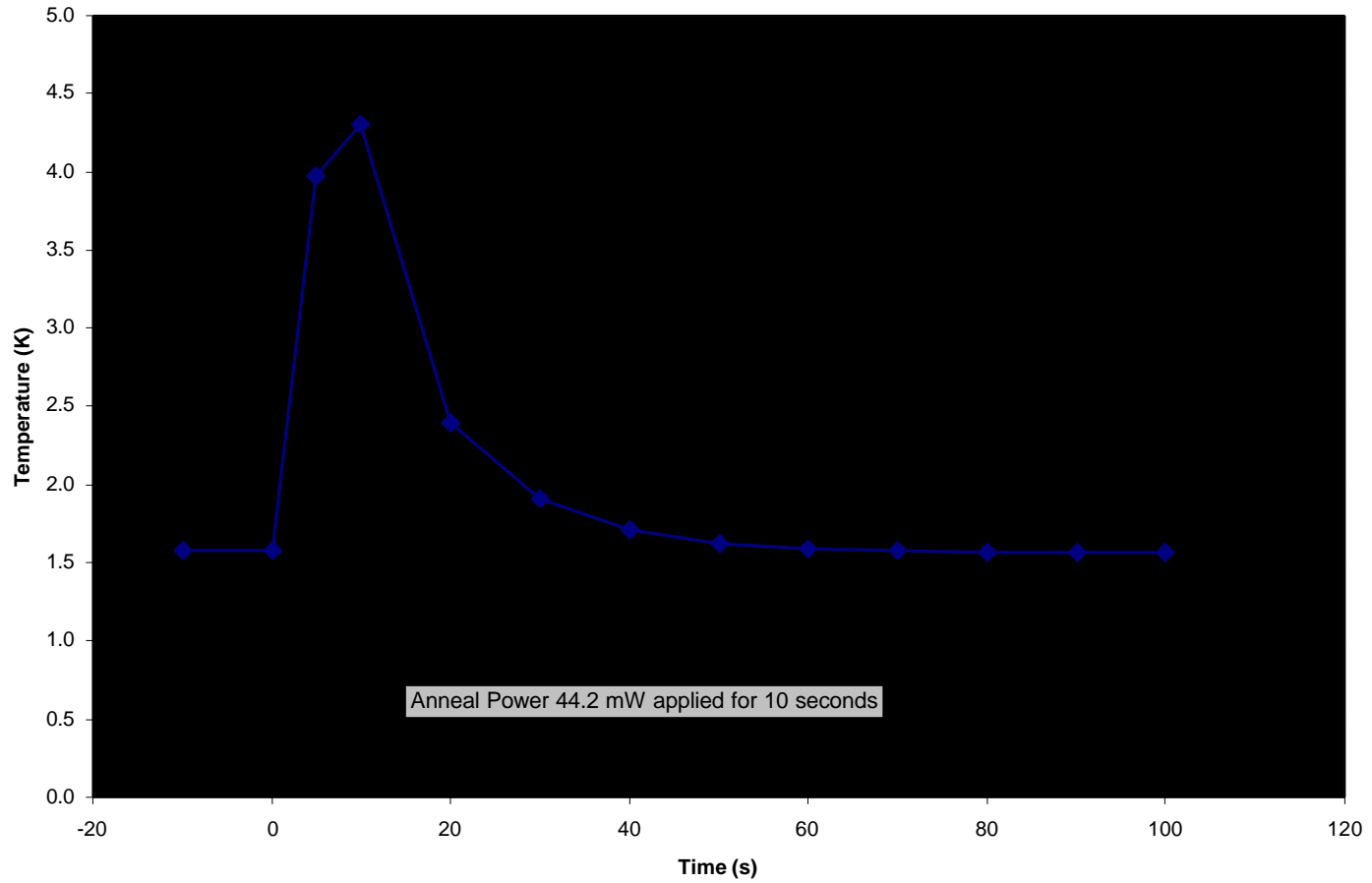
DURING EACH FRAME, EIGHT PIXELS ARE ADDRESSED PER READOUT, BUT ONLY PIXELS 2, 3, 4, 5, AND 6 ARE CONNECTED TO DETECTORS. SIGNALS APPEAR ON EIGHT PARALLEL OUTPUTS. FOR EXAMPLE, ALL PIXEL "2's" ARE ADDRESSED AND AVAILABLE AT THE SAME TIME.



Anneal Test



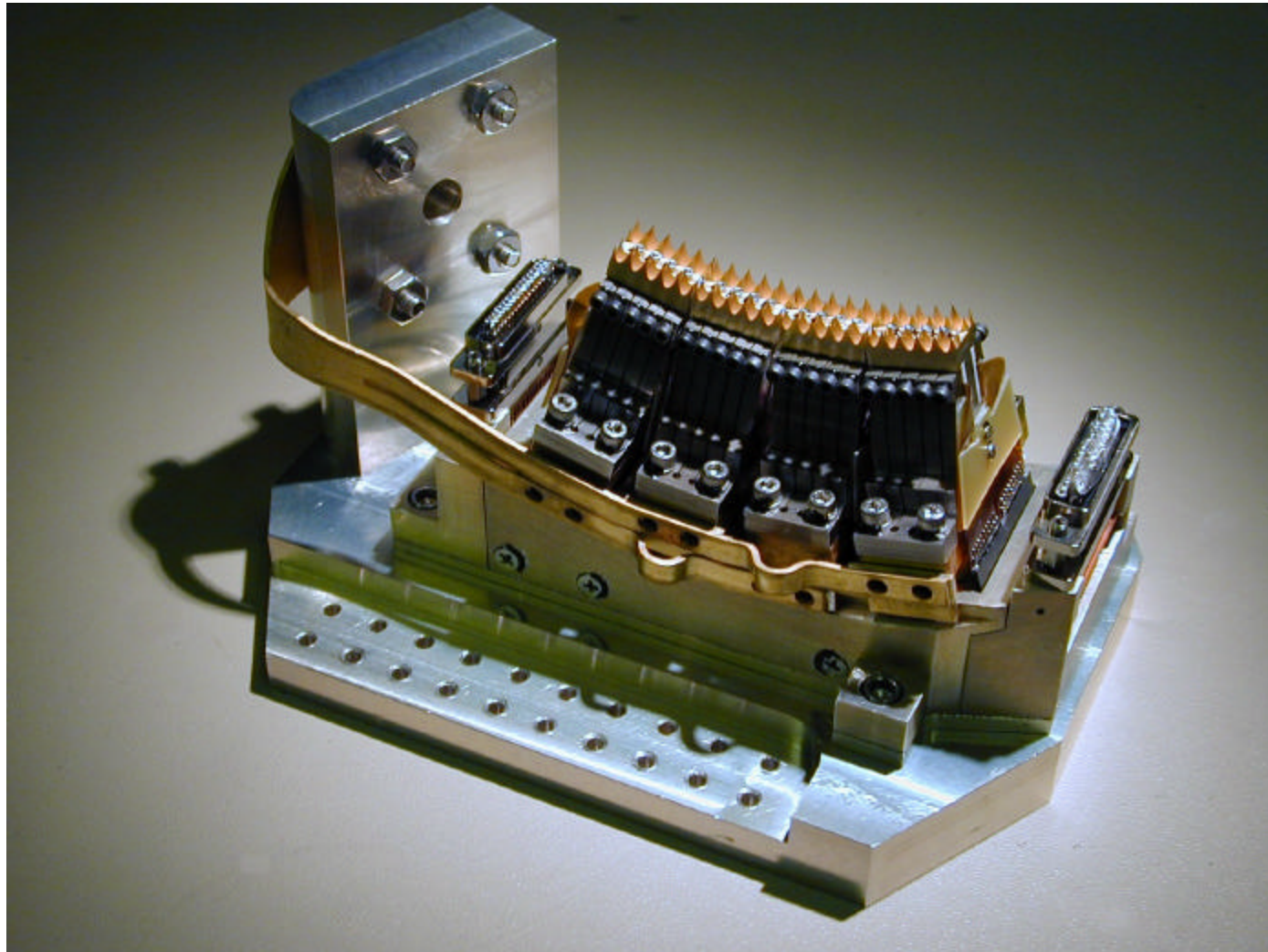
Qualification Model Stress Array Anneal Performance





Flight Stress Detector Array

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Overall Detector Status

SIRTF

- 24 μm Array
 - *Flight, Spare, and Qualification Units delivered to Ball by Boeing*
 - *Being installed today*
- 70 μm Array
 - *Flight Array has been delivered to Ball and has been installed into instrument*
 - *Flight Spare under construction*
- 160 μm Array
 - *Flight Array has been delivered to Ball and has been installed into instrument*
 - *Flight Spare under construction*



Future Prospects

SIRTF

- Advanced readouts for high backgrounds
 - *SBRC 190 readout has been fabricated to support SOFIA far-infrared arrays*
 - Switchable gains to give full wells 2×10^4 to 8×10^7 electrons
 - Built in sample and hold to eliminate time skew with rapid readout
- Larger format arrays
 - *64 x 64 Camera for SOFIA*
 - Coverage to $130 \mu\text{m}$ with Ge:Sb photoconductors